

OptiMOS[™]-5 Power Transistor





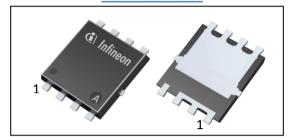
Features

- OptiMOS™ power MOSFET for automotive applications
- N-channel Enhancement mode Logic Level
- MSL1 up to 260°C peak reflow
- 175 °C operating temperature
- Green product (RoHS compliant)
- 100% Avalanche tested

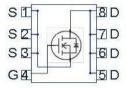
Product Summary

V_{DS}	60	٧
$R_{\mathrm{DS(on),max}}$	10	mΩ
I _D	41	Α

PG-TDSON-8-33



Туре	Package	Marking
IAUC41N06S5L100	PG-TDSON-8-33	5N06L100



Maximum ratings, at T_i =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Drain current	I _D	V _{GS} =10 V, Chip limitation ^{1,2)}	41	А
		V _{GS} =10V, DC current	41	
		T_a =85 °C, V_{GS} =10 V, R_{thJA} on 2s2p ^{2,3)}	12	
Pulsed drain current ²⁾	I _{D,pulse}	$T_{\rm C}$ =25 °C, t _p = 100 μs	115	
Avalanche energy, single pulse ²⁾	E _{AS}	I _D =20 A	37	mJ
Avalanche current, single pulse	I _{AS}	-	41	А
Gate source voltage	V_{GS}	-	±16	V
Power dissipation	P_{tot}	T _C =25 °C	42	W
Operating and storage temperature	$T_{\rm j},T_{\rm stg}$	-	-55 + 175	°C



Parameter	Symbol	Conditions		Values		Unit
			min.	typ.	max.	
Thermal characteristics ²⁾						
Thermal resistance, junction - case	R_{thJC}	-	-	-	3.6	K/W
Thermal resistance, junction - ambient ³⁾	R_{thJA}	-	1	25.5	1	

Electrical characteristics, at T_j =25 °C, unless otherwise specified

Static characteristics

Drain-source breakdown voltage	$V_{(BR)DSS}$	V_{GS} =0V, I_D =1mA	60	ı	-	V
Gate threshold voltage	$V_{\rm GS(th)}$	$V_{\rm DS}=V_{\rm GS}, I_{\rm D}=13\mu{\rm A}$	1.2	1.7	2.2	
Zero gate voltage drain current	I _{DSS}	$V_{\rm DS}$ =60V, $V_{\rm GS}$ =0V, $T_{\rm j}$ =25°C	-	1	1	μΑ
		$V_{\rm DS}$ =60V, $V_{\rm GS}$ =0V, $T_{\rm j}$ =125°C ¹⁾	-	-	100	
Gate-source leakage current	I _{GSS}	V _{GS} =16V, V _{DS} =0V	-	-	100	nA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} =4.5V, I _D =20A	-	11.6	13.9	mΩ
		V _{GS} =10V, I _D =20A	-	7.9	10	
Gate resistance ²⁾	R _G	-	-	1.1	-	Ω



Parameter	Symbol Conditions	Values			Unit	
			min.	typ.	max.	
Dynamic characteristics ²⁾						
Input capacitance	Ciss		-	927	1205	pF
Output capacitance	Coss	$V_{\rm GS}$ =0V, $V_{\rm DS}$ =30V, f =1MHz	-	183	238	
Reverse transfer capacitance	C _{rss}		-	12	18	
Turn-on delay time	t _{d(on)}		-	2.4	-	ns
Turn-off delay time	$t_{d(off)}$	V _{DD} =30V, V _{GS} =10V,	-	6.7	-	
Rise time	t _r	$I_{\rm D}$ =20A, $R_{\rm G,ext}$ =3.5 Ω	-	1.0	-	
Fall time	t _f]	-	2.2	-	
Gate to source charge	Q _{gs}	$V_{\rm DD}$ =30V, $I_{\rm D}$ =20A, $V_{\rm GS}$ =0 to 10V	-	3.0	4.0	nC
Gate to drain charge	Q _{gd}		-	2.1	3.1	
Gate charge total	Qg		-	12.7	16.4	_
Gate plateau voltage	$V_{ m plateau}$		-	3.3	-	V
Reverse Diode						
Diode continous forward current ²⁾	Is	T _C =25°C	ı	-	41	Α
Diode pulse current ²⁾	I _{S,pulse}	$T_{\rm C}$ =25 °C, $t_{\rm p}$ = 100 μs	-	-	115	
Diode forward voltage	$V_{\rm SD}$	V _{GS} =0V, I _F =20A, T _j =25°C	-	0.8	1.1	V
Reverse recovery time ²⁾	t _{rr}	V_R =30V, I_F =41A, di_F/dt =100A/ μ s	1	26	-	ns
Reverse recovery charge ²⁾	Q _{rr}		-	16	-	nC

¹⁾ Practically the current is limited by the overall system design including the customer-specific PCB.

²⁾ The parameter is not subject to production test - verified by design/characterization.

³⁾ Device on a four-layer 2s2p FR4 PCB defined in accordance with JEDEC standards (JESD51-5-7). PCB is vertical in still air.

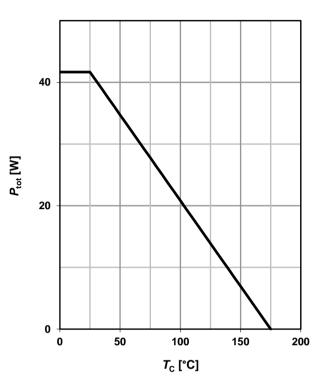


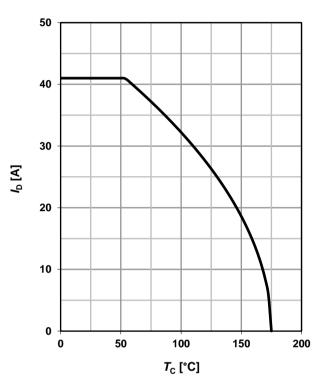
1 Power dissipation

$$P_{\text{tot}} = f(T_{\text{C}}); V_{\text{GS}} = 10 \text{ V}$$

2 Drain current

$$I_{\rm D} = f(T_{\rm C}); \ V_{\rm GS} = 10 \ {\rm V}$$





3 Safe operating area

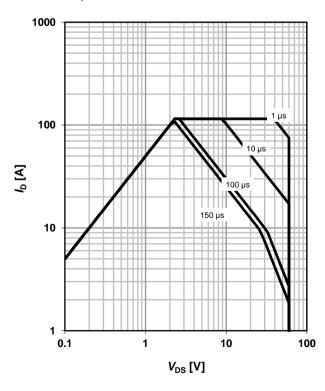
$$I_D = f(V_{DS}); T_C = 25 \text{ °C}; D = 0$$

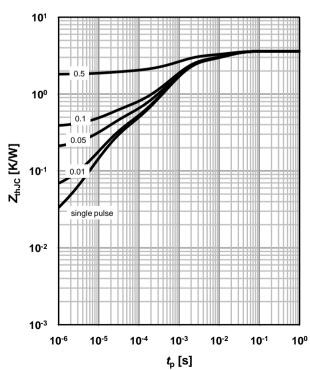
parameter: t_p

4 Max. transient thermal impedance

$$Z_{\text{thJC}} = f(t_{p})$$

parameter: $D=t_p/T$







5 Typ. output characteristics

 $I_{\rm D} = f(V_{\rm DS}); T_{\rm j} = 25 \,{}^{\circ}{\rm C}$

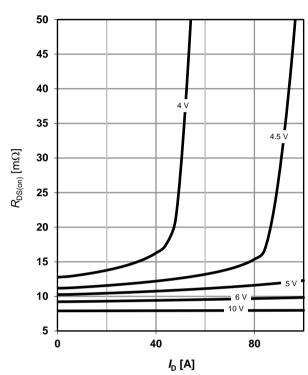
parameter: V_{GS}

120 120 45 V 45 V 40 V 50 S [V]

6 Typ. drain-source on-state resistance

 $R_{DS(on)} = f(I_D); T_j = 25 \text{ °C}$

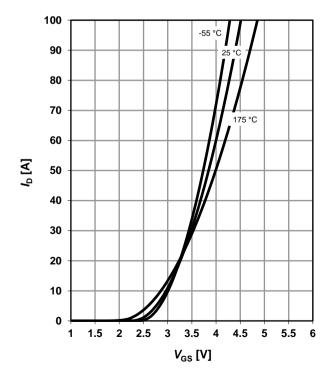
parameter: V_{GS}



7 Typ. transfer characteristics

 $I_D = f(V_{GS}); V_{DS} = 6V$

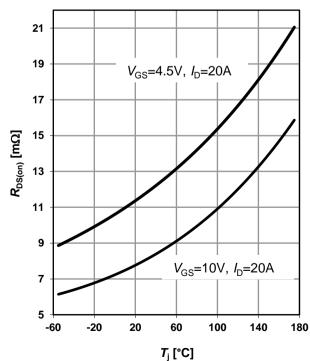
parameter: $T_{\rm j}$



8 Typ. drain-source on-state resistance

 $R_{DS(on)} = f(T_j);$

parameter: I_{D.} V_{GS}





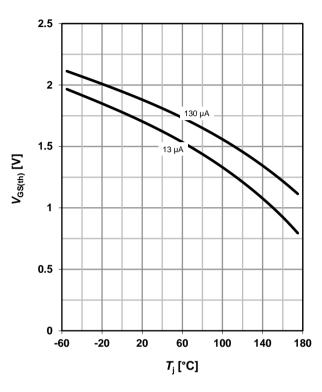
9 Typ. gate threshold voltage

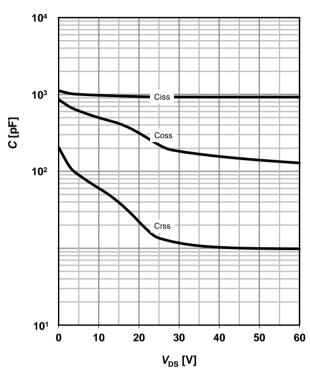
 $V_{GS(th)} = f(T_i); V_{GS} = V_{DS}$

parameter: I_D

10 Typ. capacitances

 $C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$





11 Typical forward diode characteristics

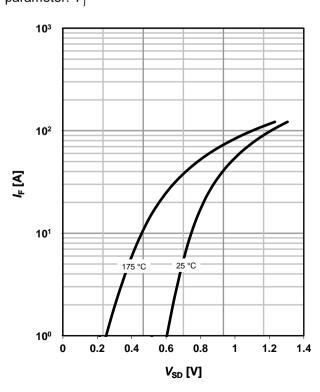
 $I_F = f(V_{SD})$

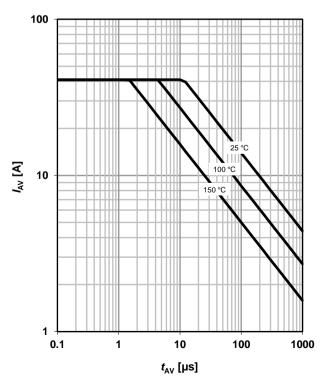
parameter: $T_{\rm j}$

12 Avalanche characteristics

 $I_{AS} = f(t_{AV})$

parameter: T_{i(start)}







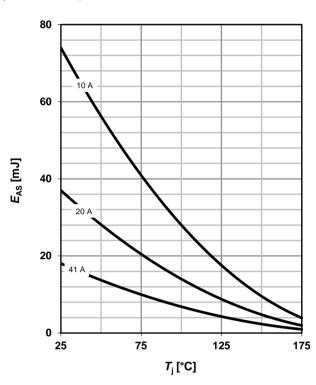
13 Avalanche energy

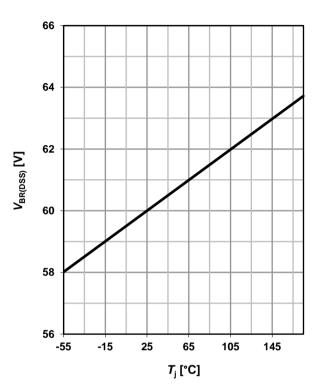
 $E_{AS} = f(T_i)$

parameter: I_D

14 Drain-source breakdown voltage

$$V_{BR(DSS)} = f(T_i); I_D = 1 \text{ mA}$$

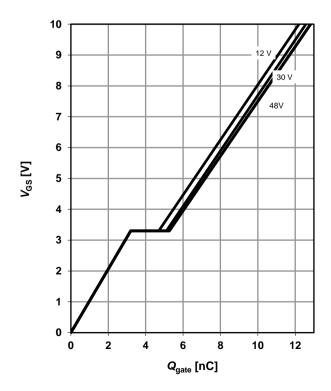




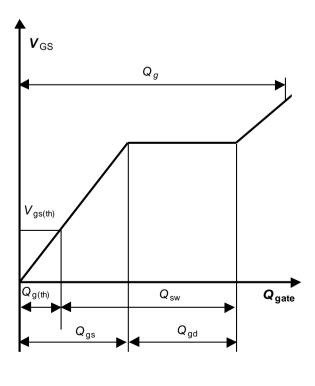
15 Typ. gate charge

 $V_{GS} = f(Q_{gate}); I_D = 20 A pulsed$

parameter: V_{DD}

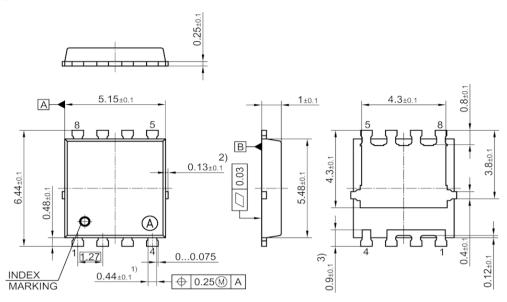


16 Gate charge waveforms



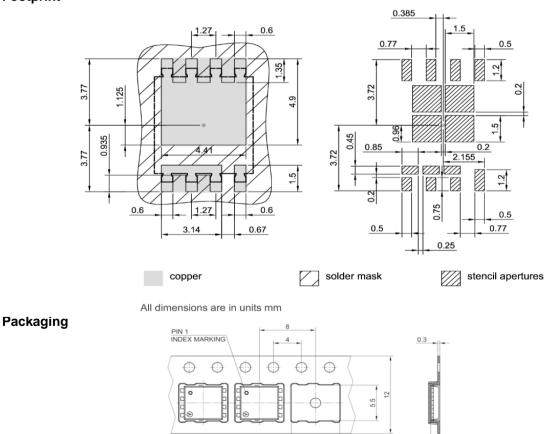


Package Outline



- 1) EXCLUDE MOLD FLASH
 2) REMOVAL ON MOLD GATE, INTRUSION 0.1MM AND PROTRUSION 0.1MM
 3) LEAD LENGTH UP TO ANTI FLASH LINE
 4)ALL METAL SURFACE ARE PLATED, EXCEPT AREA OF CUT
 ALL DIMENSIONS ARE IN UNITS MM
 THE DRAWING IS IN COMPLIANCE WITH ISO 128 & PROJECTION METHOD 1 [

Footprint





Published by Infineon Technologies AG 81726 Munich, Germany

© Infineon Technologies AG 2020 All Rights Reserved.

Legal Disclaimer

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics. With respect to any examples or hints given herein, any typical values stated herein and/or any information regarding the application of the device, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation, warranties of non-infringement of intellectual property rights of any third party.

Information

For further information on technology, delivery terms and conditions and prices, please contact the nearest Infineon Technologies Office (www.infineon.com).

Warnings

Due to technical requirements, components may contain dangerous substances. For information on the types in question, please contact the nearest Infineon Technologies Office. Infineon Technologies components may be used in life-support devices or systems only with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support device or system or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body or to support and/or maintain and sustain and/or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.

in they fail, it is reasonable to assume that the meaning in the aser of other persons may be chadingered.



Revision History

Version	Date	Changes
Revision 1.0	05.05.2020	Final Data Sheet